

ABSOLUTE MAXIMUM RATINGS

These are stress ratings only and functional operation of the device at these ratings or any other above those indicated in the operation sections of the specifications below is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

Cathode-Anode Reverse Breakdown V_{KA} 20V
 Anode-Cathode Forward Current, ($<10\text{ms}$) I_{AK} 1A
 Operating Cathode Current I_{KA} 100mA
 Reference Input Current I_{REF} 10mA
 Continuous Power Dissipation at 25°C PD
 TO-92 775mW
 SOT-89 1000mW
 Storage Temperature T_{STG} -65 to 150°C
 Lead Temperature (Soldering 10 sec.) T_L 300°C

OPERATING RATINGS

Input Voltage Range V_{KA} V_{REF} to 20V
 Cathode Current I_K 10mA
 Junction Temperature Range 150 °C
 Thermal Resistance
 θ_{JA} (TO-92) 160°C/W
 θ_{JC} (TO-92) 80°C/W
 Typical Derating (TO-92) 6.3 mW/°C

 θ_{JA} (SOT-89) 110°C/W
 θ_{JC} (SOT-89) 8°C/W
 Typical Derating (SOT-89) 9.1 mW/°C

ELECTRICAL SPECIFICATIONS

Specifications with standard type are for an Operating Junction Temperature of $T_A = 25^\circ\text{C}$ only; limits applying over the full Operating Junction Temperature range are denoted by a "•". Minimum and Maximum limits are guaranteed through test, design, or statistical correlation. Typical values represent the most likely parametric norm at $T_A = 25^\circ\text{C}$, and are provided for reference purposes only. Unless otherwise indicated, $I_K = 10\text{mA}$ $V_K = V_{REF}$.

Parameter	Min.	Typ.	Max.	Units	Conditions
SPX431LA					
Reference Voltage	2.490	2.503	2.515	V	
ΔV_{REF} with Temp. ¹		0.07	0.20	mV/°C	
Ratio of Change in V_{REF} to Cathode Voltage	-2.7 -2.0	-1.0 -0.4	0.3	mV/V	V_{REF} to 10V V_{REF} to 10V
Reference Input Current		0.7	4.0	μA	
IREF Temp Deviation		0.4	1.2	μA	$T_J = 0^\circ\text{C}$ to 105°C
Min I_K for Regulation		0.4	1.0	mA	
Off State Leakage		0.04	1.0	μA	$V_{REF} = 0\text{V}$, $V_{KA} = 20\text{V}$
Dynamic Output Impedance		0.15	0.5	Ω	$f_z \leq 1\text{kHz}$ $I_K = 1$ to 100mA
SPX431L					
Reference Voltage	2.470	2.495	2.520	V	
ΔV_{REF} with Temp. ¹		0.07	0.20	mV/°C	
Ratio of Change in V_{REF} to Cathode Voltage	-2.7 -2.0	-1.0 -0.4	0.3	mV/V	V_{REF} to 10V V_{REF} to 10V
Reference Input Current		0.7	4.0	μA	
IREF Temp Deviation		0.4	1.2	μA	$T_J = 0^\circ\text{C}$ to 105°C
Min I_K for Regulation		0.4	1.0	mA	
Off State Leakage		0.04	1.0	μA	$V_{REF} = 0\text{V}$, $V_{KA} = 20\text{V}$
Dynamic Output Impedance		0.15	0.5	Ω	$f_z \leq 1\text{kHz}$ $I_K = 1$ to 100mA
SPX431LC					
Reference Voltage	2.445	2.495	2.520	V	
ΔV_{REF} with Temp. ¹		0.07	0.20	mV/°C	
Ratio of Change in V_{REF} to Cathode Voltage	-2.7 -2.0	-1.0 -0.4	0.3	mV/V	V_{REF} to 10V V_{REF} to 10V
Reference Input Current		0.7	4.0	μA	
IREF Temp Deviation		0.4	1.2	μA	$T_J = 0^\circ\text{C}$ to 105°C

Precision Adjustable Shunt Regulator

Parameter	Min.	Typ.	Max.	Units	Conditions
Min I_K for Regulation		0.4	1.0	mA	
Off State Leakage		0.04	1.0	μA	$V_{REF} = 0V, V_{KA} = 20V$
Dynamic Output Impedance		0.15	0.5	Ω	$f_z \leq 1kHz$ $I_K = 1$ to $100mA$

Note 1: See appropriate test circuit (Figures 25, 26, 27)

PIN ASSIGNMENT

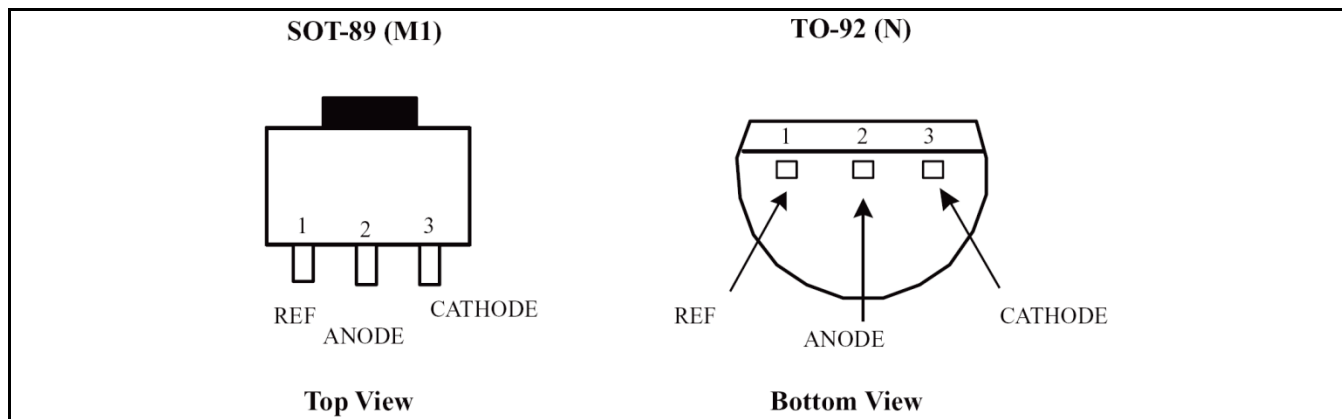


Fig. 2: SPX431L Pin Assignment

PIN DESCRIPTION

Name	Pin Number	Description
NAME	1	Reference
NAME	2	Anode
NAME	3	Cathode

ORDERING INFORMATION

Part Number	Temperature Range	Marking	Package	Packing Quantity	Note 1	Note 2
SPX431LAN-L	0°C to 105°C	Sipex 431LAN 25 YYWWLX	TO-92-3	Bulk	Halogen Free	2.503V 0.5% Acc
SPX431LAN-L/TR				Tape & Reel		
SPX431LM1-L	0°C to 105°C	P011 YWXXXX	SOT-89-3	Bulk	Halogen Free, bar on left side of marking denotes "-L" lead free product	2.495V 1.0% Acc
SPX431LM1-L/TR				Tape & Reel		
SPX431LN-L	0°C to 105°C	Sipex 431LN 25 YYWWLX	TO-92-3	Bulk	Halogen Free	2.495V 1.0% Acc
SPX431LN-L/TR				Tape & Reel		

"YY" = Year (Last 2 digits) – "Y" = Year (Last Digit)

"WW" = Work Week

"L" = Lead free designator

"X" = Lot Number (example AA234567) – "XXX" = Lot Number (example AA23456Z)

No bottom marking

TYPICAL PERFORMANCE CHARACTERISTICS

Schematic and BOM from Application Information section of this datasheet. Resistor values are chosen such that the effect to I_{REF} is negligible.

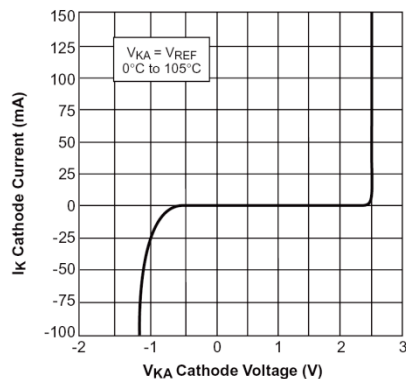


Fig. 3: High Current Operating Characteristics

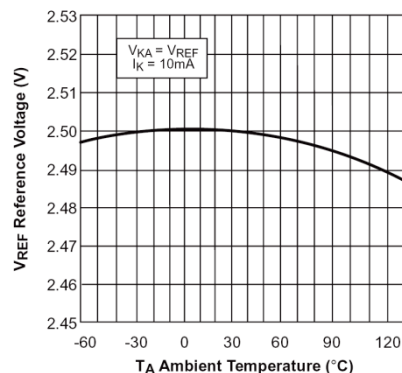


Fig. 4: Reference Voltage VS Ambient Temperature

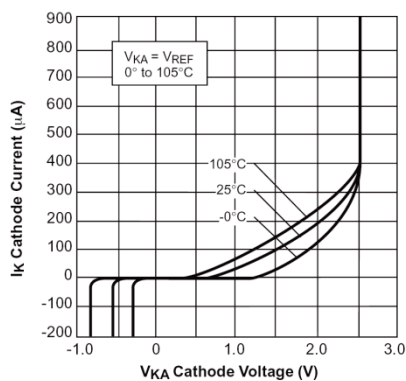


Fig. 5 Low Current Operating Characteristics.

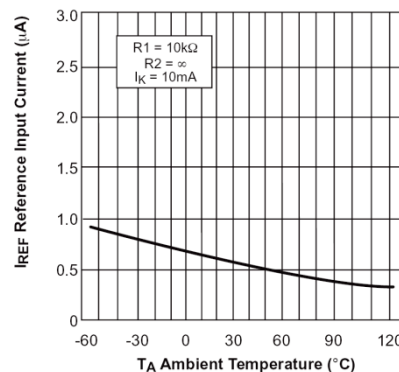


Fig. 6 Reference Input Current VS Ambient Temperature.

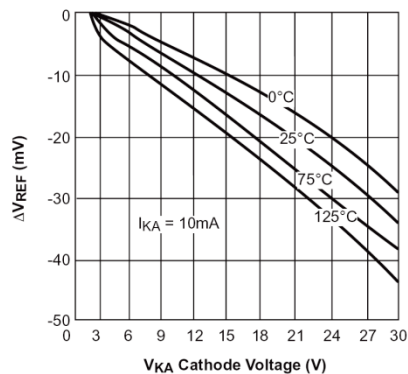


Fig. 7 Reference Voltage Line Regulation VS Cathode Voltage and $T_{AMBIENT}$

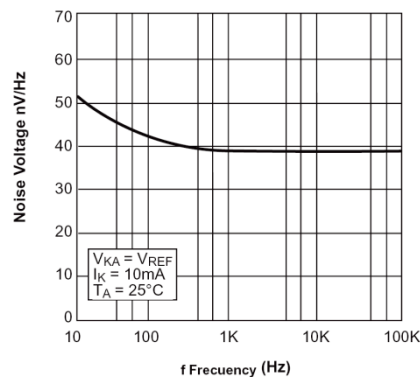


Fig. 8 Noise Voltage VS Frequency

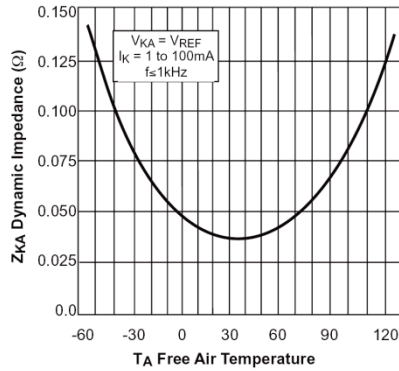


Fig. 9 Low Frequency Dynamic Output Impedance
VS TAMBIENT

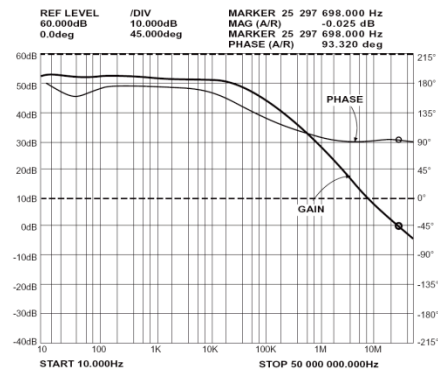


Fig. 10 Small Signal Gain and Phase VS Frequency;
 $I_K = 10\text{mA}$, $T_A = 25^\circ\text{C}$

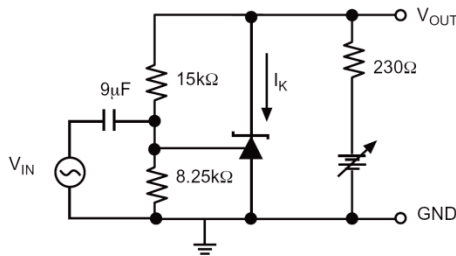


Fig. 11 Test Circuit for Gain and Phase Frequency
Response

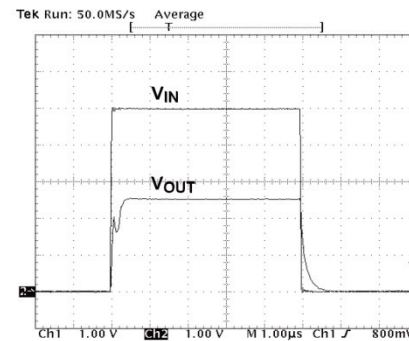


Fig. 2 $F_z = 100\text{kHz}$, $I_K = 10\text{mA}$, $T_A = 25^\circ\text{C}$

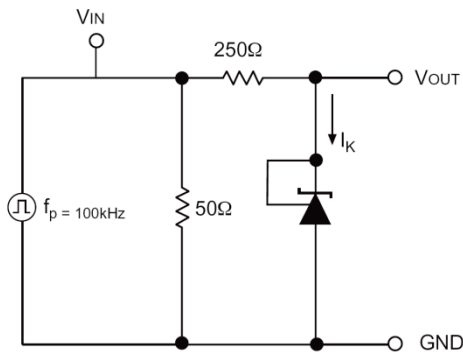


Fig. 33 Test Circuit for Pulse Response

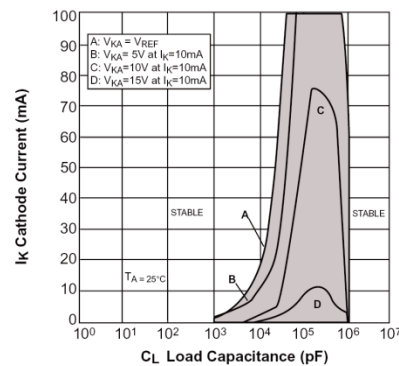


Fig. 44 Stability Boundry Conditions

Precision Adjustable Shunt Regulator

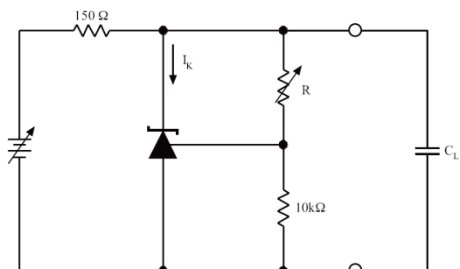


Fig. 55 Test Circuit for Stability

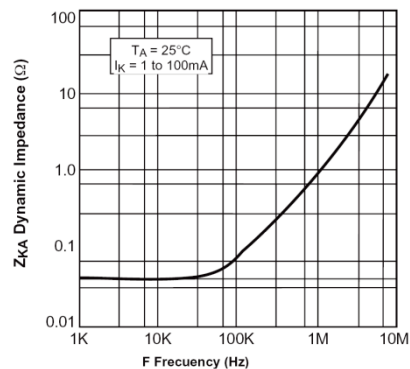


Fig. 66 Dynamic Output Impedance T_A = 25°C,
I_k = 1 to 100mA

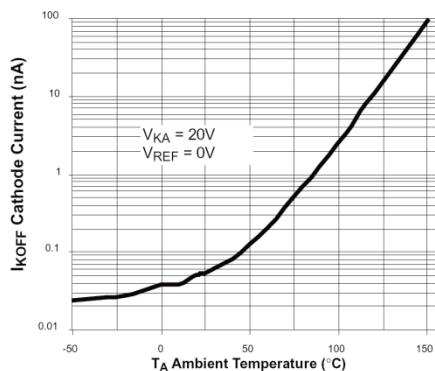


Fig. 77 Off State Leakage

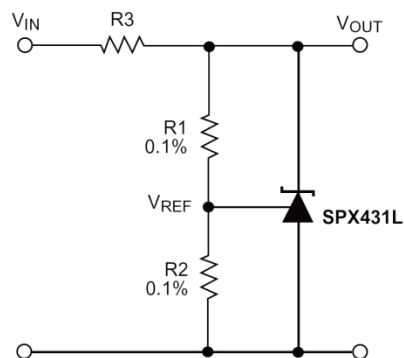


Fig. 88 Shunt Regulator V_{OUT} = (1+R1/R2)V_{REF}

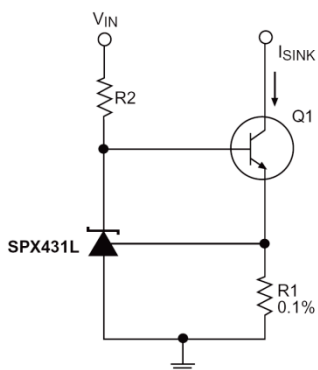


Fig. 199 Constant Current Sink, I_{SINK} = V_{REF}/R1

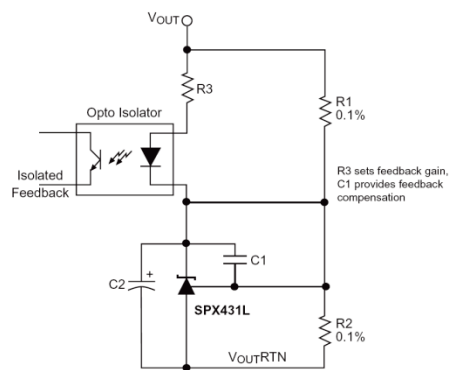


Fig. 100 Reference Amplifier for Isolated Feedback in
Off-Line DC-DC Converters

Precision Adjustable Shunt Regulator

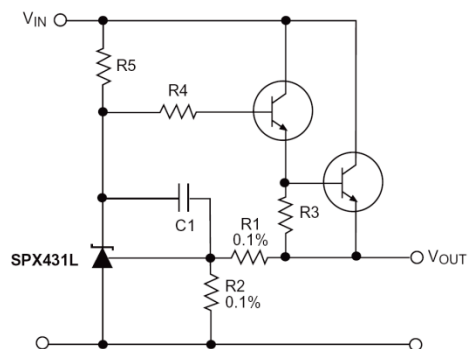


Fig. 111 Precision High Current Series Regulator
 $V_{OUT} = (1 + R1/R2)V_{REF}$

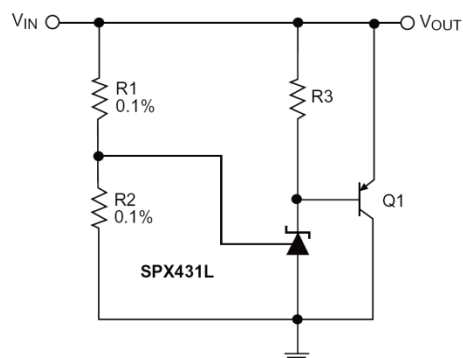


Fig. 122 High Current Shunt regulator
 $V_{OUT} = (1 + R1/R2)V_{REF}$

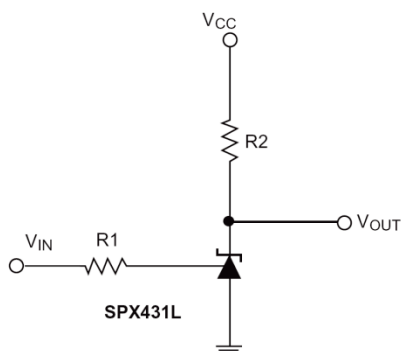


Fig. 133 Single Supply Comparator with Temperature
Compensated Threshold. V_{IN} threshold = 2.5V.

APPLICATION INFORMATION

CALCULATING AVERAGE TEMPERATURE COEFFICIENT (TC)

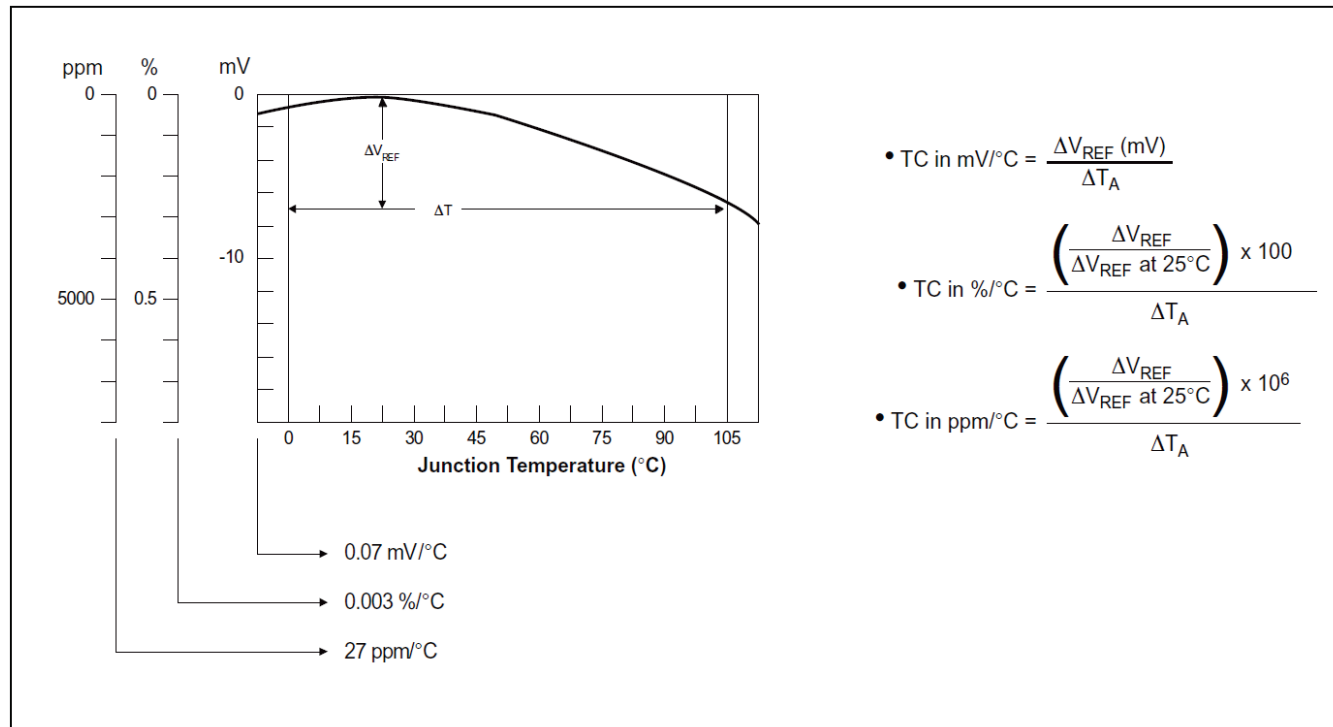


Fig. 24: V_{REF} VS Temperature.

TEST CIRCUITS

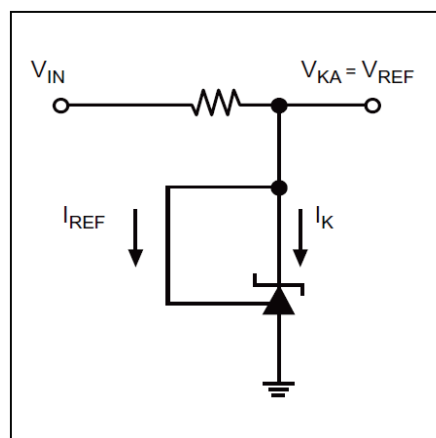


Fig. 25: Test Circuit for $V_{KA} = V_{REF}$

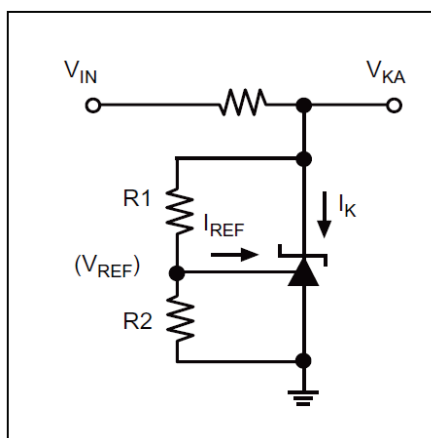


Fig. 26: Test Circuit for $V_{KA} > V_{REF}$

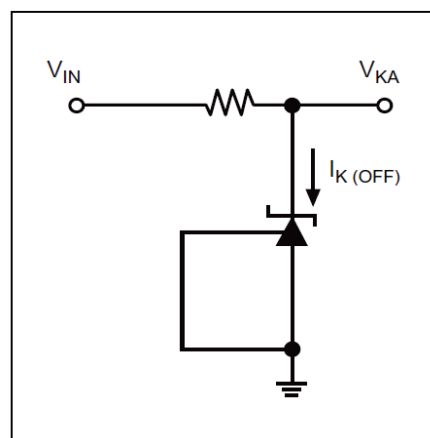
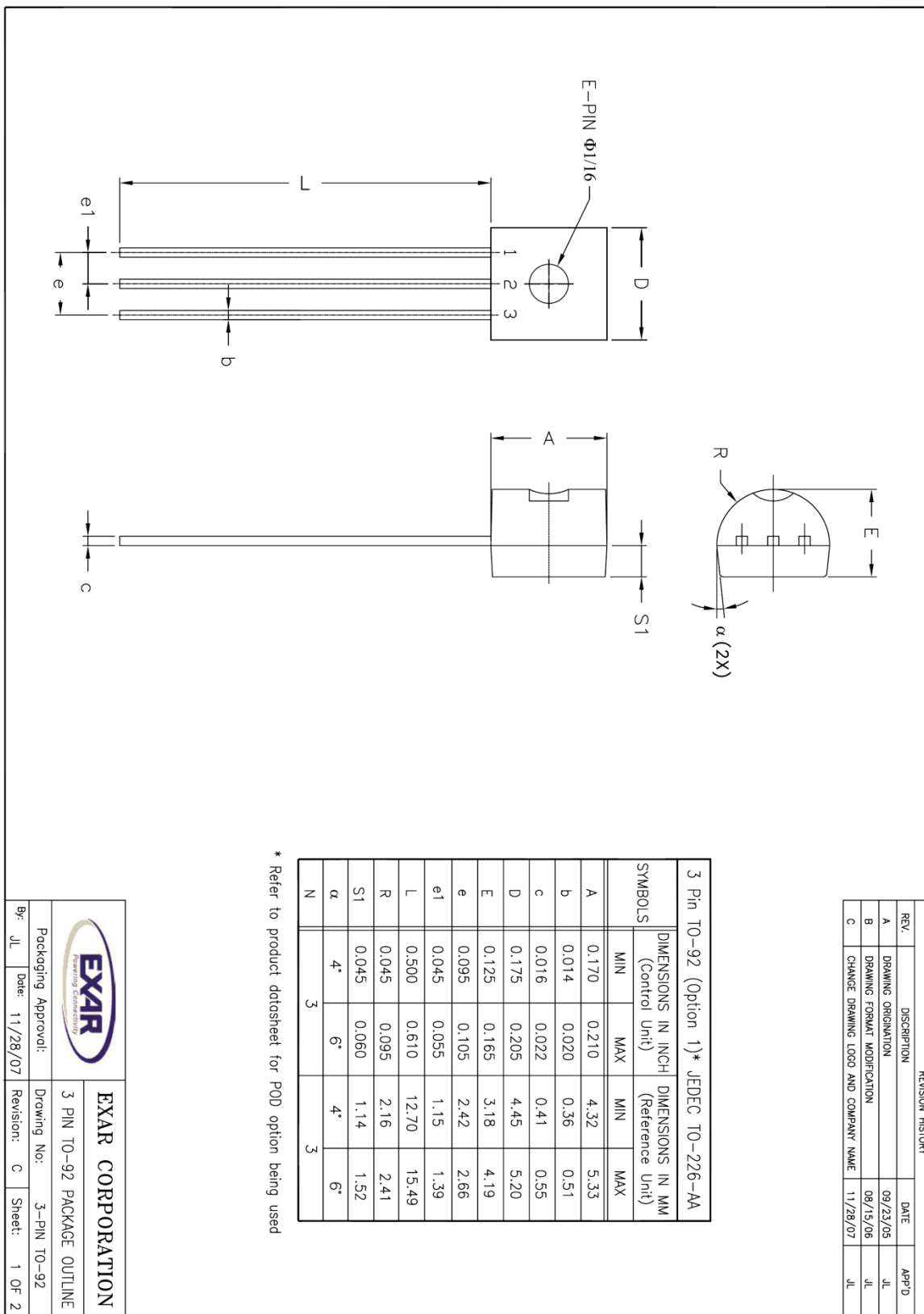


Fig. 27: Test Circuit for I_{KOFF}

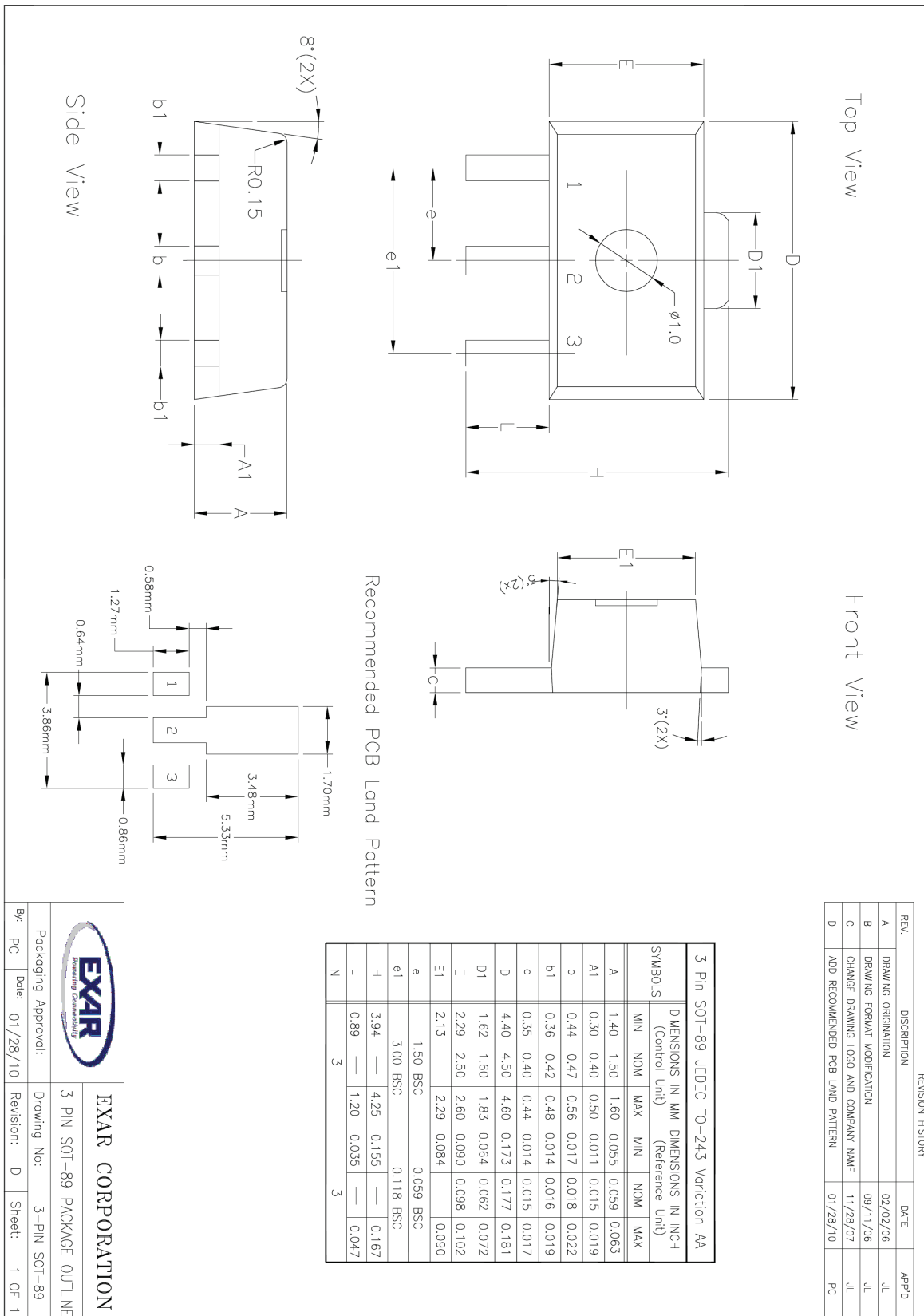
PACKAGE SPECIFICATION

3 PIN TO-92



PACKAGE SPECIFICATION

3 PIN SOT-89



REVISION HISTORY

Revision	Date	Description
2.0.0	06/12/2012	Reformatted Datasheet. Corrected Package Drawing
2.0.1	07/19/2013	Update package marking information and updated corporate logo.

FOR FURTHER ASSISTANCE

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